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Jung Kim -

09/402,144 Examiner

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	SEAR	CHED	
Class	Subclass	Date	Examiner
713	161,170, 181	2/17/2007	JK
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INT	INTERFERENCE SEARCHED		
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
updated east search	2/17/2007	JK
updated inventor name search on palm; no double patenting issues	2/17/2007	JK
see enclosed search record		
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